

# SPEAR 3 DCCT

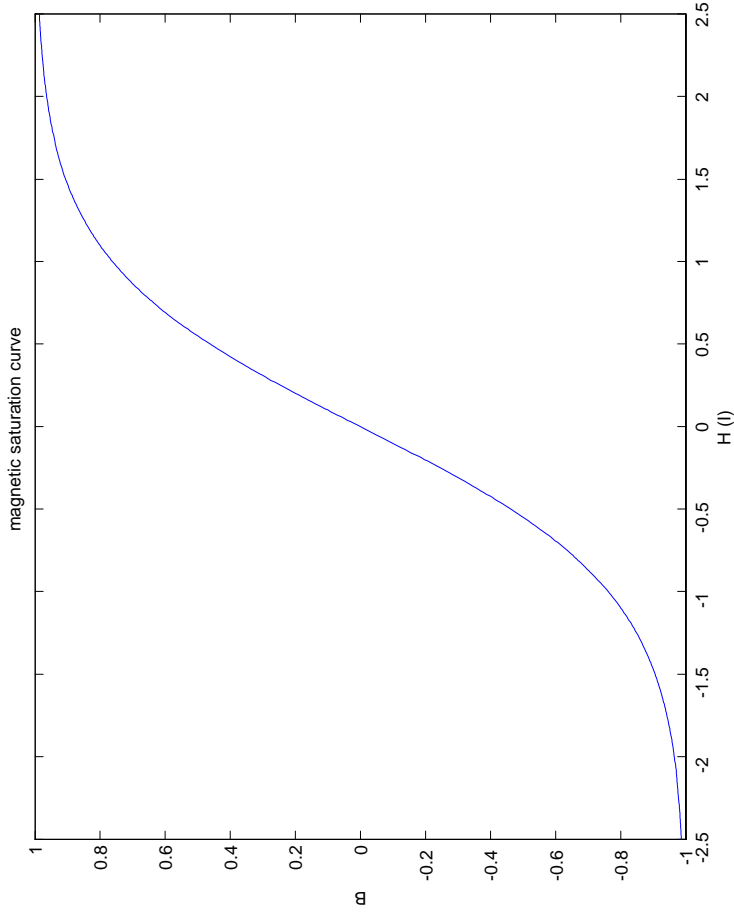
J. Sebek

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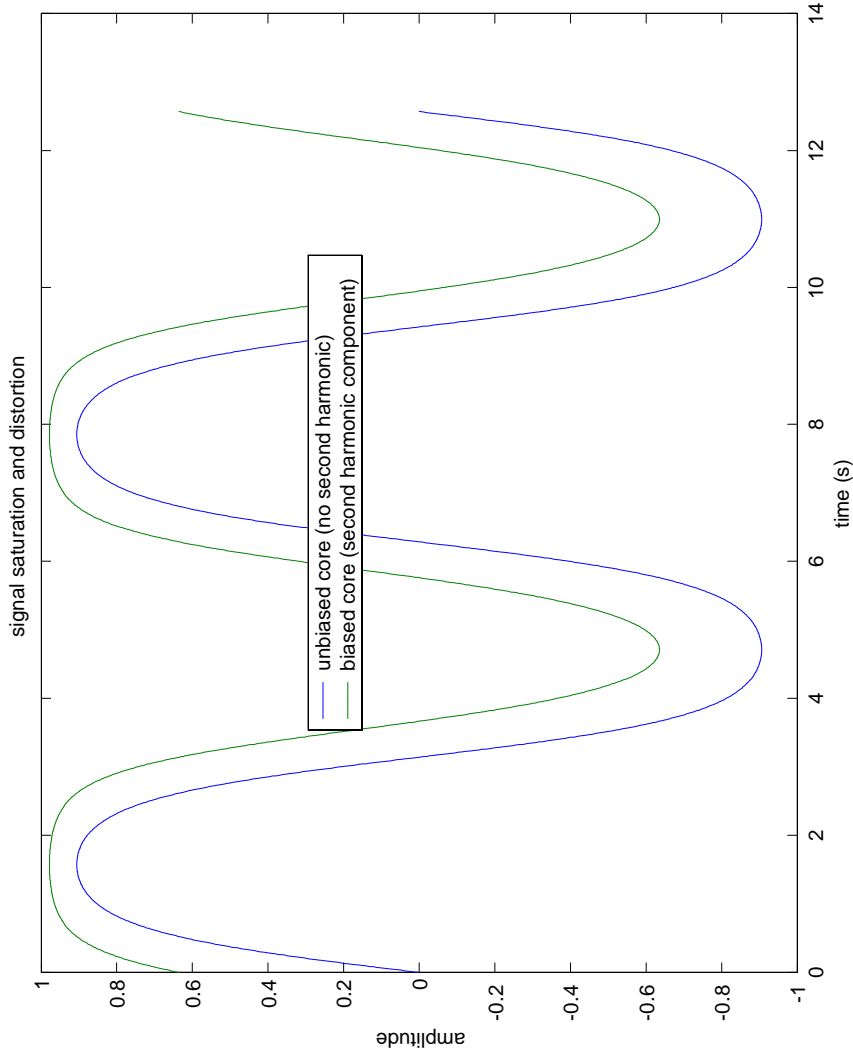
## 1 Outline

- Zero flux transducer theory
- Circuitry details
- *SPEAR 3* DCCT design
- System resolution and lifetime calculations

## 2 Zero Flux Transducer Theory

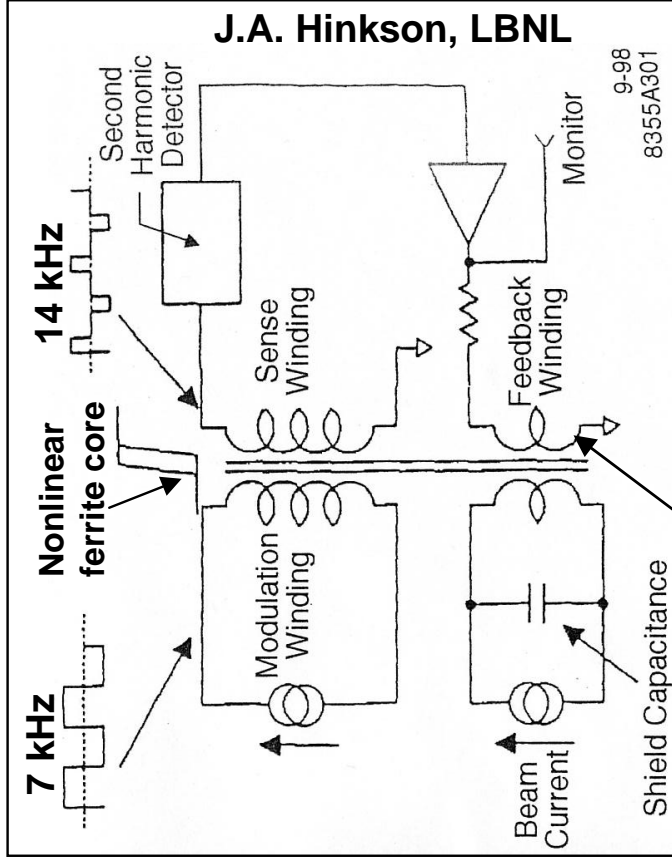


- Magnetic elements are non-linear
- Magnetic flux density,  $B$ , saturates with increasing magnetic field,  $H$

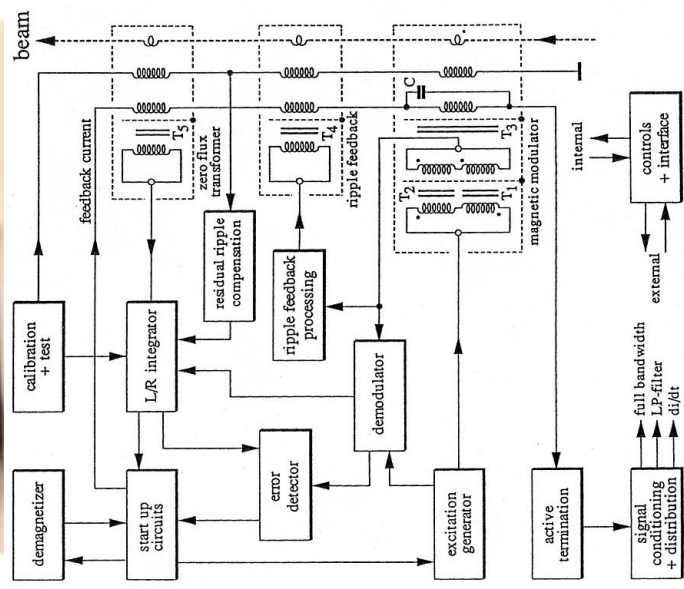
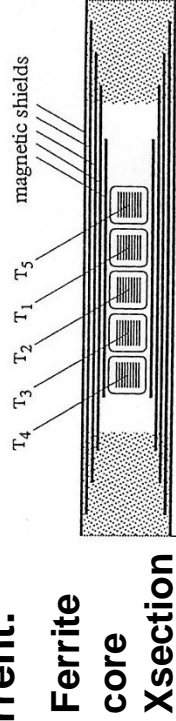


- If magnetic element is biased,  $\langle \mathbf{H} \rangle \neq 0$ ,  $2^{nd}$  harmonic distortion occurs
- $2^{nd}$  harmonic distortion detects net flux in element
- Sense  $2^{nd}$  harmonic and feedback control current through element until  $\langle \mathbf{H} \rangle = 0$

# DCCT (or PCT) circuit



The DC bias current is adjusted to remove the 2<sup>nd</sup> harmonic (14 kHz) response of toroid. The beam current is proportional to the DC bias current.

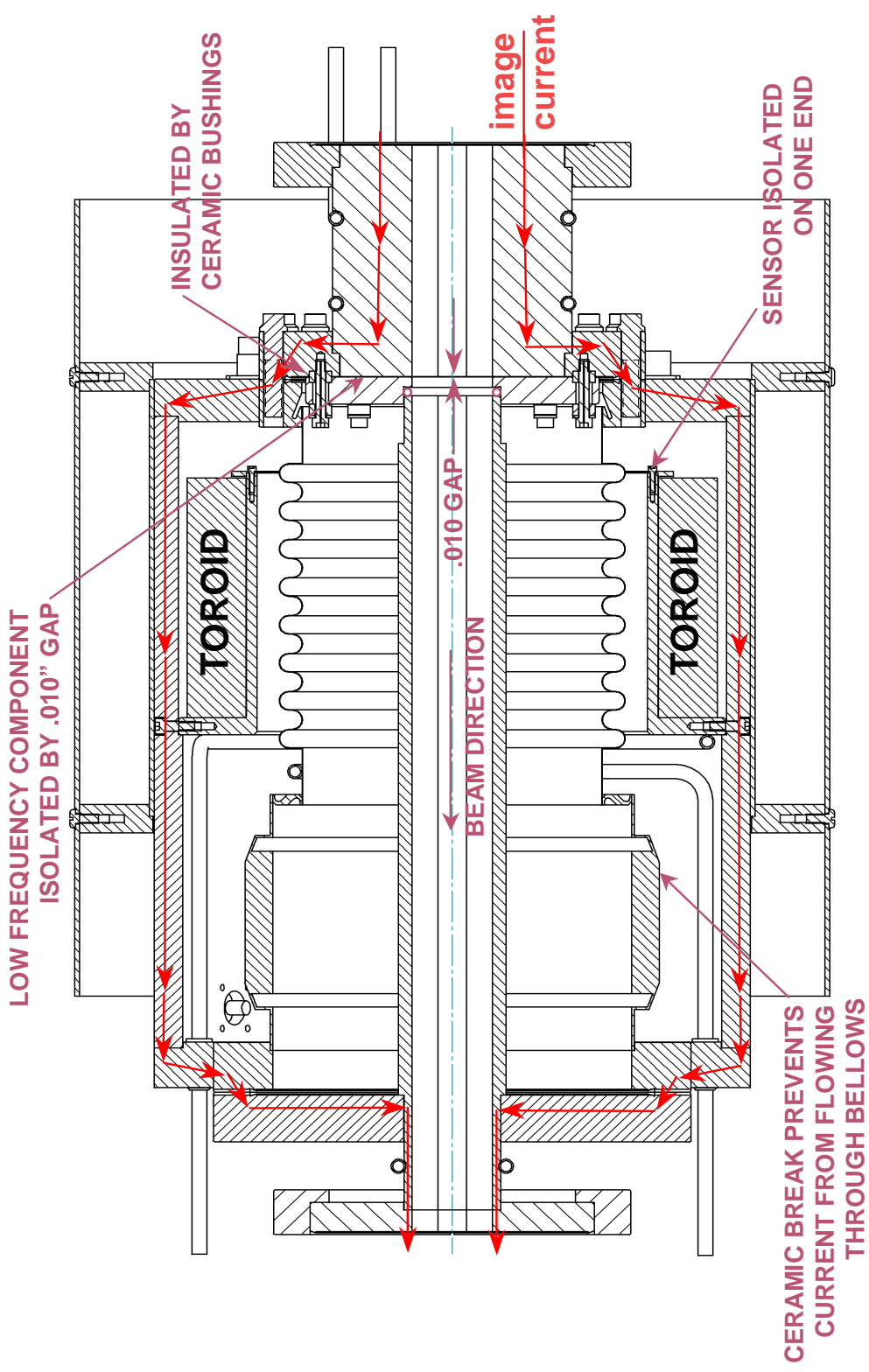


Simplified circuit, K. Unser, 1992

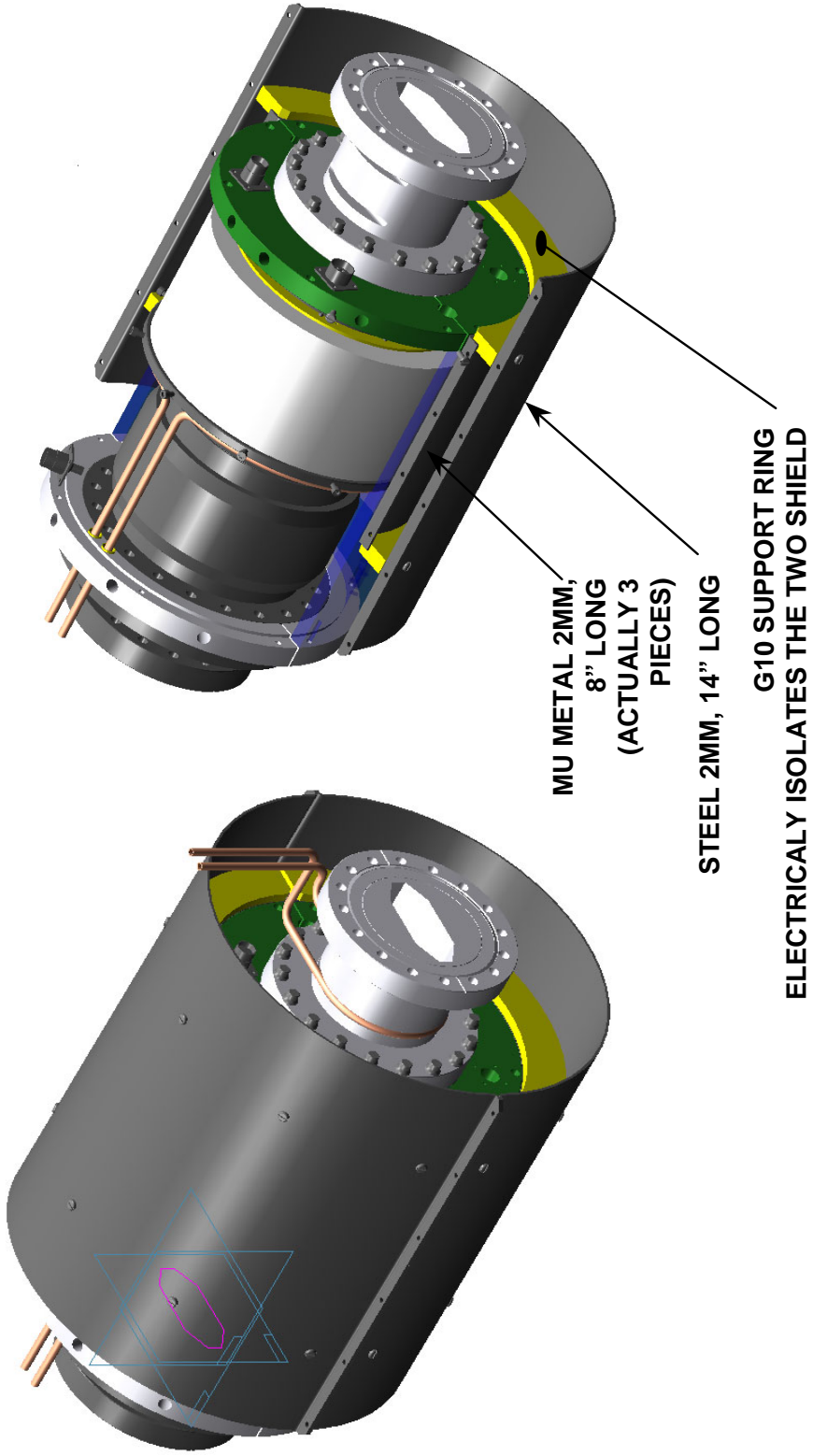
### 3 SPEAR 3 DCCT Design

- Beam carries image current along with it
  - Image current on vacuum chamber wall
  - Need the beam current, but not the image current, to pass through the toroid
- Need a break in the metallic chamber wall, but still want to minimize beam impedance
  - Small gap in vacuum chamber
- Keep as much of the toroid out of the ring vacuum as possible
  - Place large ceramic break inside toroid inner diameter
- Minimize heating effects from beam induced RF effects on toroid
- Maintain high precision of system
  - Shield the toroid from stray fields that could bias the toroid
- Create a workable mechanical design
- *SPEAR 3* design by D. Arnett, N. Kurita, and J. Safranek

# SPEAR3 DCCT



# Shielding



## 4 System Resolution and Lifetime Calculations

- SPEAR current

$$\begin{aligned} 500 \text{ mA} &= Q \cdot f_{rev} \\ Q &= 3.91 \times 10^{-7} \text{ C} \\ &= 2.44 \times 10^{12} e^- \end{aligned}$$

- Beam lifetime

$$\begin{aligned} I(t) &\cong I_0 \exp(-t/\tau) \\ &\cong I_0 (1 - t/\tau), \quad t \ll \tau \end{aligned}$$

– For  $t \ll \tau$ , lifetime can be found from a linear fit

- For  $\tau = 40 \text{ h}$  lifetime

$$\begin{aligned} N_{rev} &= 40 \cdot 60 \cdot 60 \cdot f_{rev} \\ &= 1.84 \times 10^{11} \end{aligned}$$

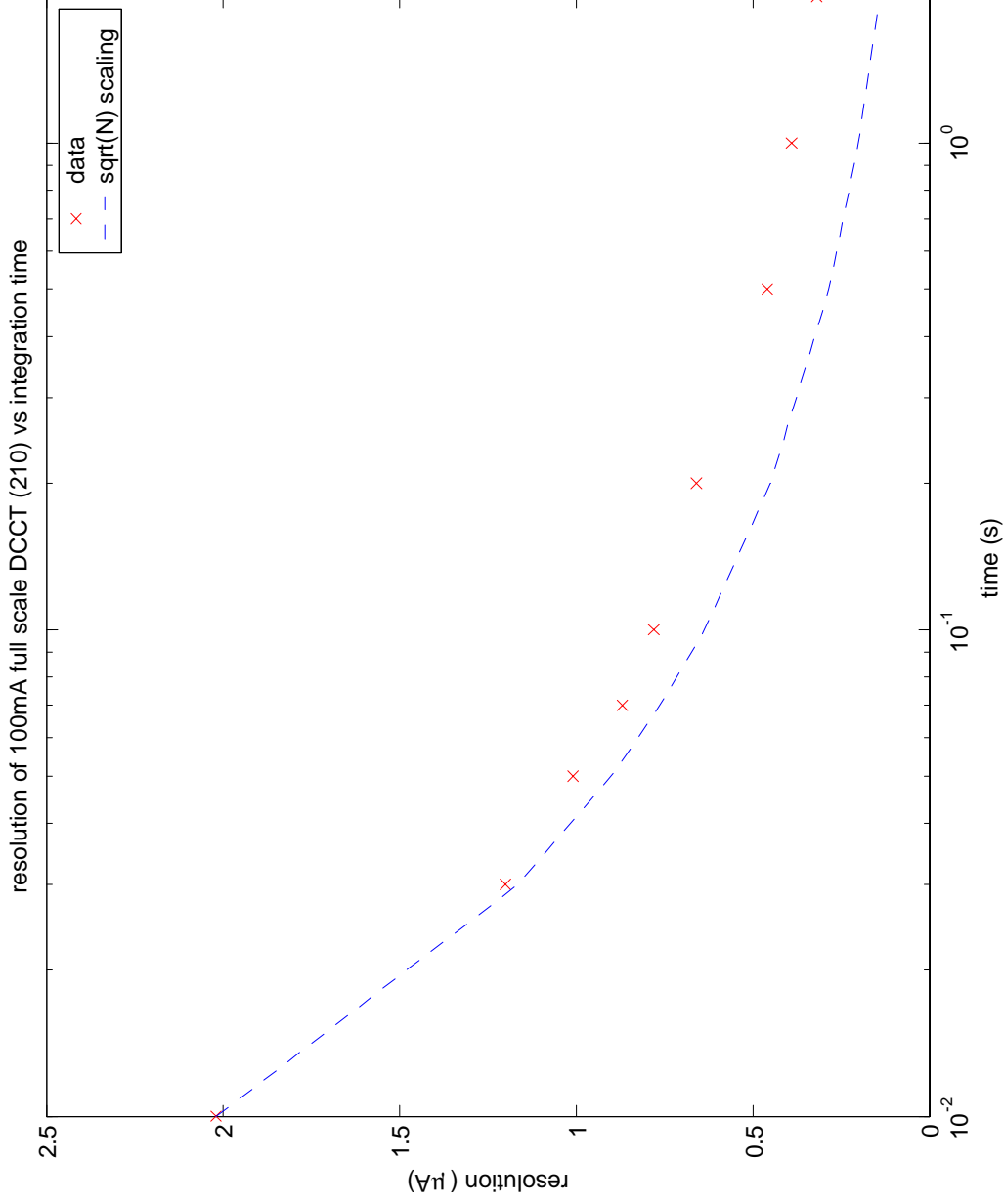
- Lose  $\simeq 13 e^-$  per revolution



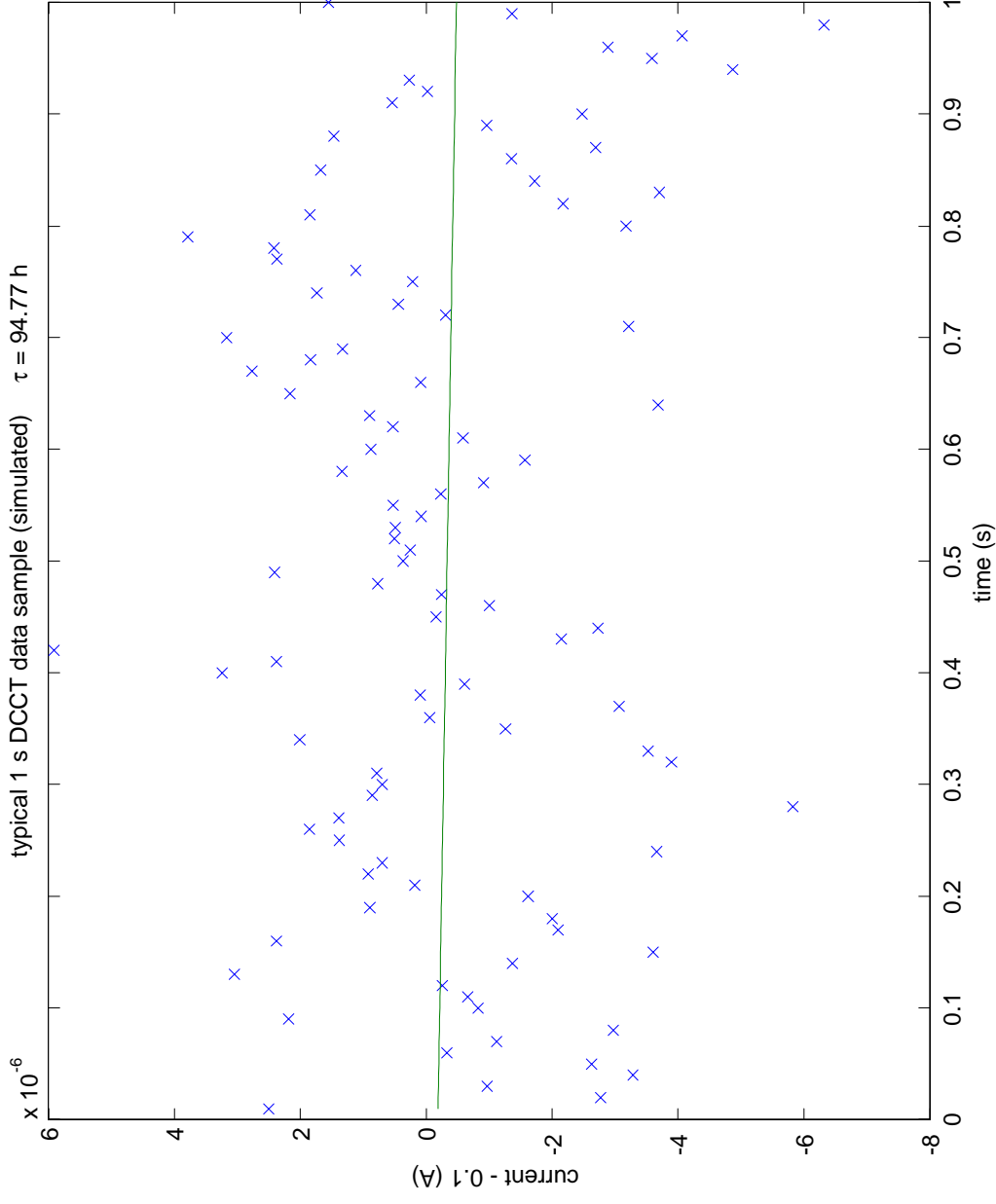
- Difference between two lifetimes

$$I_0 [\exp(-t/\tau_1) - \exp(-t/\tau_2)] \cong I_0 \left[ -t \left( \frac{1}{\tau_1} - \frac{1}{\tau_2} \right) \right] \\ \cong -I_0 \frac{\Delta\tau}{\tau^2} t$$

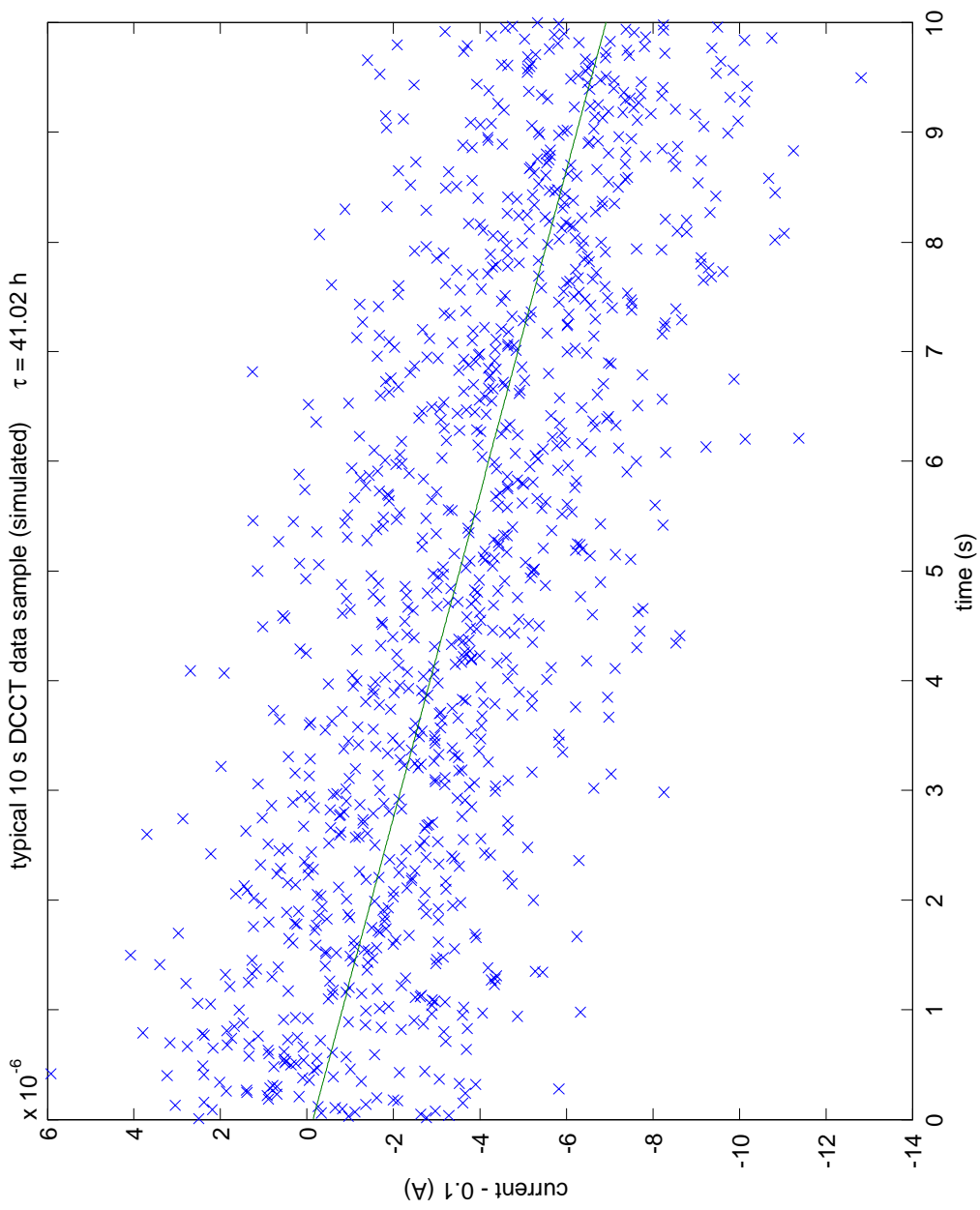
- To distinguish between different lifetimes, need to know the current to within an accuracy
- $$\frac{\Delta I}{I} = \frac{\Delta\tau t}{\tau \tau}$$
- For  $\tau = 40 \text{ h}$ ,  $\tau = 144000 \text{ s}$



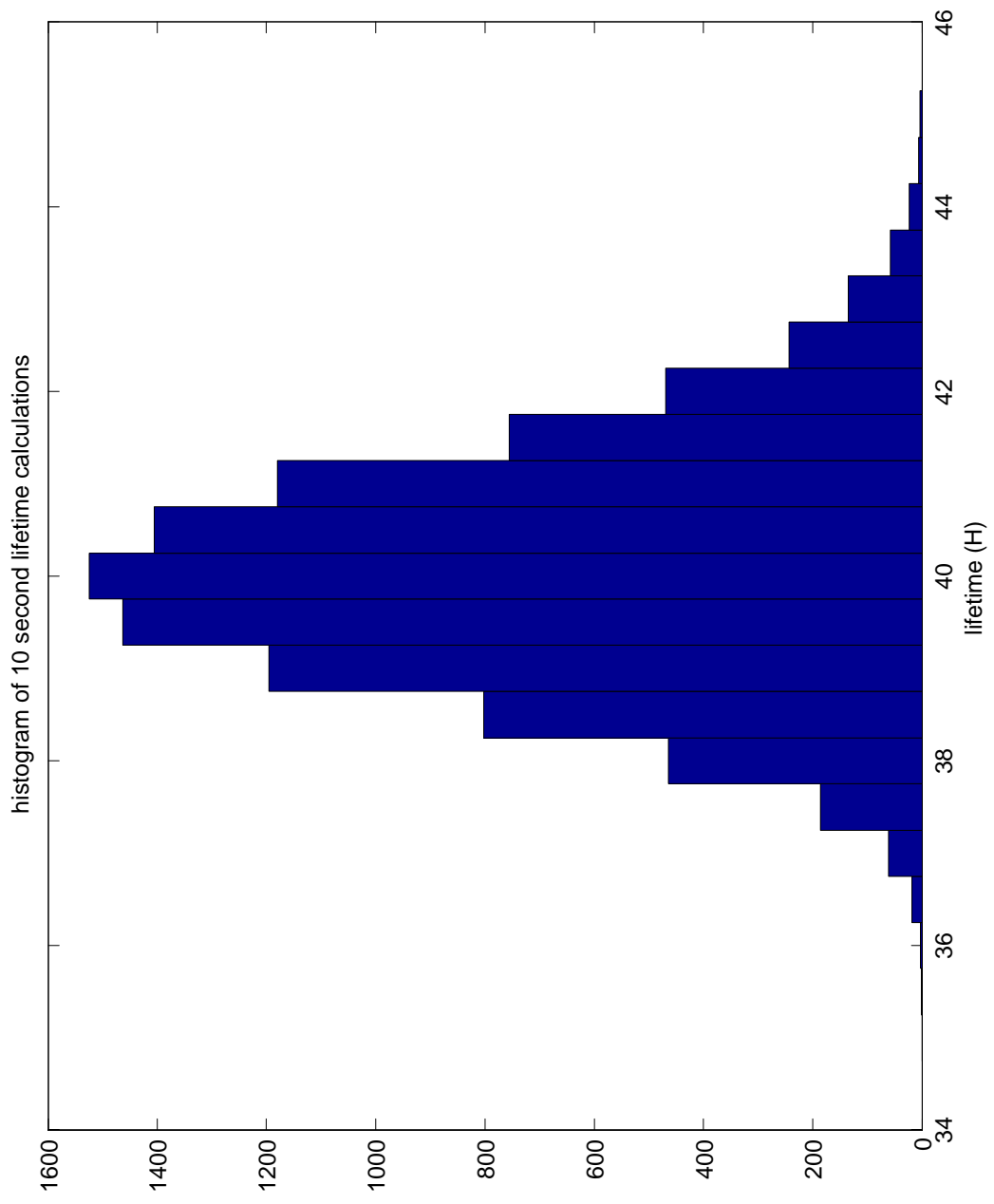
- Bergoz electronics has resolution of  $2\ \mu\text{A}$  out of  $100\ \text{mA}$  ( $2 \times 10^{-5}$ ) in 10 ms
- Noise almost decreases as  $N^{-1/2}$  with increasing sample number
- Keithley DVM has 6.5 digit accuracy ( $< 1 \times 10^{-6}$ ) at 250 samples per second



- Can acquire  $\sim 100$  samples per second from DVM
- System noise greatly limits accuracy of lifetime calculation in 1 s



- Accuracy becomes quite good after 1000 samples are taken in 10s



- 40 h lifetime calculations are now accurate to within 3%

## 5 Lifetime Calculation Summary

- Lifetime accuracy dominated by electronic noise from DCCT electronics
- Perform experiments with 100 mA in SPEAR so that the more sensitive scale of the electronics can be used
- 40 h lifetime measurements can be performed with 3% accuracy with 1000 samples in 10 s